


<b>Search Notes</b>  	<b>Application/Control No.</b>  10585194	<b>Applicant(s)/Patent Under Reexamination</b>  OHNO ET AL.
	<b>Examiner</b>  Don P Le	<b>Art Unit</b>  2819

SEARCHED			
Class	Subclass	Date	Examiner
333	245-248, 254	3/3/2008	dl

SEARCH NOTES		
Search Notes	Date	Examiner
east + interference	6/4/2008	dl

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
	see search notes	6/4/2008	dl